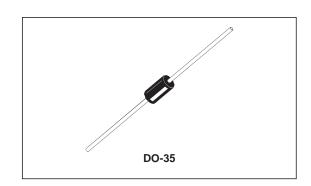


# SMALL SIGNAL SCHOTTKY DIODE

## **DESCRIPTION**

Metal to silicon junction diode featuring high breakdown, low turn-on voltage and ultrafast switching. Primarly intended for high level UHF/VHF detection and pulse application with broad dynamic range.



**ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter	Value	Unit
$V_{RRM}$	Repetitive Peak Reverse Voltage	60	V
l <sub>F</sub>	Forward Continuous Current*	15	mA
I <sub>FSM</sub>	Surge non Repetitive Forward Current*	50	mA
$T_{stg} \ T_{j}$	Storage and Junction Temperature Range	- 65 to 200 - 65 to 200	°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering of from Case	230	°C

# THERMAL RESISTANCE

Symbol	Test Conditions	Value	Unit
R <sub>th(j-a)</sub>	Junction-ambient*	400	°C/W

# **ELECTRICAL CHARACTERISTICS**

### STATIC CHARACTERISTICS

Symbol		Test Conditions	Min.	Тур.	Max.	Unit
$V_{BR}$	T <sub>amb</sub> = 25°C	$I_R = 10\mu A$	60			V
V <sub>F</sub> * *	T <sub>amb</sub> = 25°C	$I_F = 1 \text{mA}$			0.41	V
	T <sub>amb</sub> = 25°C	$I_F = 15mA$			1	
I <sub>R</sub> * *	T <sub>amb</sub> = 25°C	V <sub>R</sub> = 50V			0.2	μΑ

#### DYNAMIC CHARACTERISTICS

Symbol	Test Conditions			Min.	Тур.	Max.	Unit
С	T <sub>amb</sub> = 25°C	$V_R = 0V$	f = 1MHz			2.2	pF
τ	T <sub>amb</sub> = 25°C	$I_F = 5mA$	Krakauer Method			100	ps

<sup>\*</sup> On infinite heatsink with 4mm lead length \*\* Pulse test:  $t_p \! \leq \! 300 \mu s \; \delta < \! 2\%$  .

Matched batches available on request. Test conditions (forward voltage and/or capacitance) according to customer specification.

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**Fig. 1:** Forward current versus forward voltage (typical values).

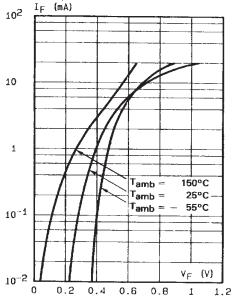


Fig. 2: Capacitance C versus reverse applied voltage  $V_{_{\rm R}}$  (typical values).

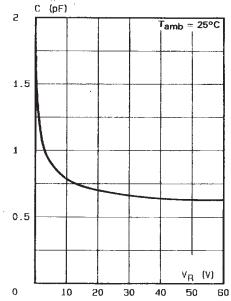
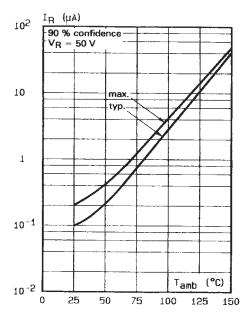
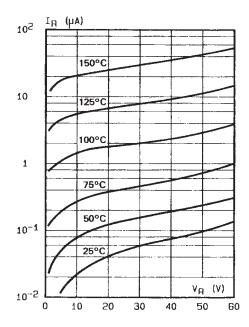


Fig. 3: Reverse current versus ambient temperature.



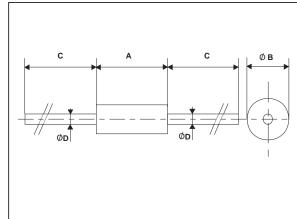
**Fig. 4:** Reverse current versus continuous reverse voltage (typical values).



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#### PACKAGE MECHANICAL DATA

DO-35



REF.	DIMENSIONS				
	Millimeters		Inches		
	Min.	Max.	Min.	Max.	
А	3.05	4.50	0.120	0.177	
В	1.53	2.00	0.060	0.079	
С	28.00		1.102		
D	0.458	0.558	0.018	0.022	

Cooling method: by convection and conduction Marking: clear, ring at cathode end. Weight: 0.15g

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